

Application/Control No.	Applicant(s)/Patent under Reexamination
09/842,604	HE, HAIXIANG
Examiner	Art Unit
Hai V. Nguyen	2142

SEARCHED					
Class	Subclass	Date	Examiner		
updated		7/31/2007	HN		
370	254-256	7/31/2007	HN		

INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
	1				

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
EAST Search Updated (US-PGPUB; USPAT; USOCR; EPO; JPO, DERWENT, IBM_TDB) (see search history printout report)	7/31/2007	HN		
Limited classified search; 370/ 254- 256 (see search history printout report)	7/31/2007	HN		